

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination				
		10736229	MATSUYAMA, SHIGERU				
Examiner		Nguyen, Kimhung	Art Unit	2629			
ORIGINAL							
INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS	CLAIMED			NON-CLAIMED	
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CROSS REFERENCE(S)							
SUBCLASS (ONE SUBCLASS PER BLOCK)							
CLASS		87	100	104			
345							
 RICHARD HJERPE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner)				Total Claims Allowed: 20			
Kimhung Nguyen (Assistant Examiner)  Michael P. Lutzen (Legal Instruments Examiner)		8/30/06 (Date)	RICHARD HJERPE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner)		O.G. Print Claim(s) 1		O.G. Print Figure 1